

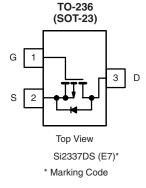
P-Channel 80-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)		
- 80	0.270 at V _{GS} = - 10 V	- 2.2	7		
	0.303 at $V_{GS} = -6 \text{ V}$	- 2.1	,		

FEATURES

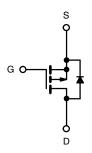
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET





Ordering Information: Si2337DS-T1-E3 (Lead (Pb)-free)

Si2337DS-T1-GE3 (Lead (Pb)-free and Halogen-free)



P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	- 80	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		- 2.2		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C		- 1.75		
Continuous Diain Current (1) = 150 C)	T _A = 25 °C	I _D	- 1.2 ^{b, c}		
	T _A = 70 °C		- 0.96 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 7	^	
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	- 2.1	- - -	
Continuous Source-Drain Diode Current	T _A = 25 °C	ls —	- 0.63 ^{b, c}		
Avalanche Current	L = 0.1 mH	I _{AS}	11		
Single-Pulse Avalanche Energy		E _{AS}	6.0	mJ	
	T _C = 25 °C		2.5	W	
Maximum Power Dissipation	T _C = 70 °C	P _D	1.6		
Maximum Power Dissipation	T _A = 25 °C	' D	0.76 ^{b, c}		
	T _A = 70 °C		0.48 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature	,	260	7		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	120	166	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	40	50	- °C/vv		

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 166 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				1			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 80			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 35.8		\//00	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	Ι _D = - 250 μΑ		5.45		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 2		- 4	٧	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Wallana Busin Oamani		V _{DS} = - 80 V, V _{GS} = 0 V			- 1		
ro Gate Voltage Drain Current I_{DSS} $V_{DS} = -80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$				- 10	μΑ		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = -10 \text{ V}$	- 7			Α	
		V _{GS} = - 10 V, I _D = - 1.2 A	0.216 0.2		0.270	1 -	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 6 V, I _D = - 1.1 A		0.242	0.303	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 1.2 A		4.3		S	
Dynamic ^b	•			1			
Input Capacitance	C _{iss}			500		pF	
Output Capacitance	C _{oss}	V _{DS} = - 40 V, V _{GS} = 0 V, f = 1 MHz		40			
Reverse Transfer Capacitance	C _{rss}			25			
Total Gate Charge	Qg	V _{DS} = - 40 V, V _{GS} = - 10 V, I _D = - 1.2 A		11	17.0		
				7	11.0	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = -40 \text{ V}, V_{GS} = -6 \text{ V}, I_{D} = -1.2 \text{ A}$		2.1			
Gate-Drain Charge	Q_{gd}			3.2			
Gate Resistance	R _g	f = 1 MHz		4.8		Ω	
Turn-On Delay Time	t _{d(on)}			10	15		
Rise Time	t _r	V_{DD} = - 40 V, R_L = 42 Ω		15	23	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 0.96 A, V_{GEN} = - 10 V, R_g = 1 Ω		20	30		
Fall Time	t _f			15	23		
Turn-On Delay Time	t _{d(on)}			15	23		
Rise Time	t _r	V_{DD} = - 40 V, R_L = 42 Ω		18	27		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 0.96 A, V_{GEN} = - 6 V, R_g = 1 Ω		20	30		
Fall Time	t _f			12	18		
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 2.1	Δ	
Pulse Diode Forward Current ^a	I _{SM}				- 7	А	
Body Diode Voltage	V_{SD}	I _S = 0.63 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			30	45	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 0.63 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		45	70	nC	
Reverse Recovery Fall Time	ta	$11F - 0.003 \text{ A}, \text{ di/dt} = 1000 \text{ A/}\mu\text{s}, 1 \text{ J} = 25 \text{ C}$		25		ns	
Reverse Recovery Rise Time	t _b			5			

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

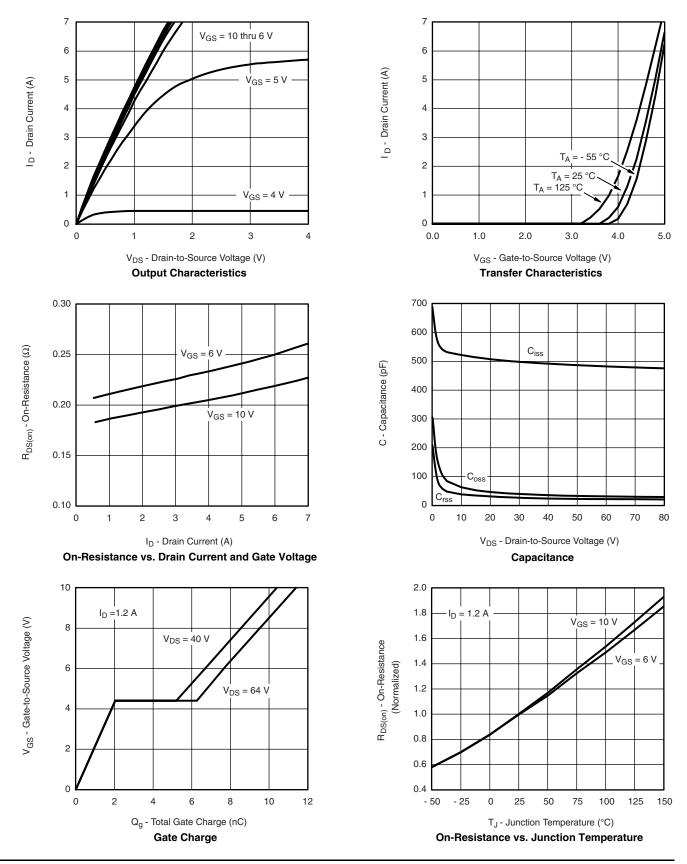
b. Guaranteed by design, not subject to production testing.







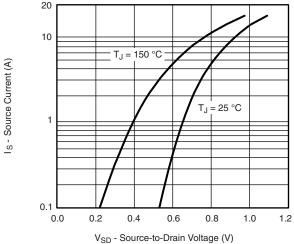
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



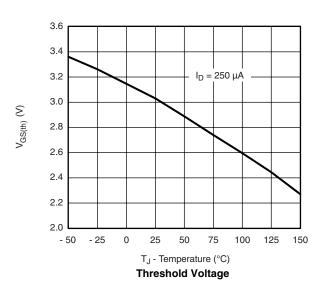
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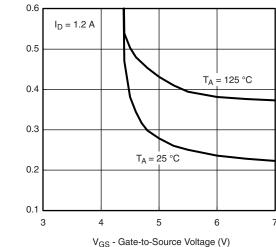
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



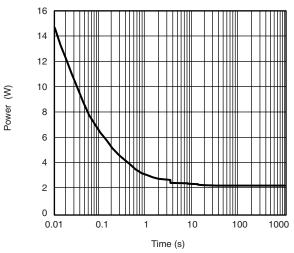
Source-Drain Diode Forward Voltage



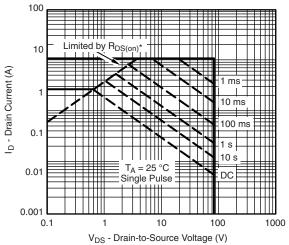
 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$ - Drain-to-Source On-Resistance (Ω)



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

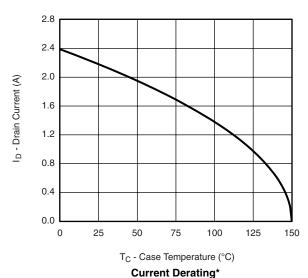
Safe Operating Area, Junction-to-Ambient

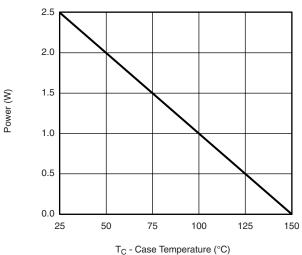






TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





Power Derating

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 $T_{A} = \frac{L \cdot I_{A}}{BV \cdot V_{DD}}$ 1.0E-6 10.0E-6 100.0E-6 1.0E-3 10.0E-3

T_A - Time In Avalanche (s)

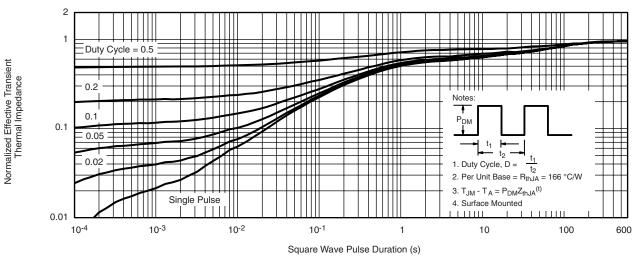
Single Pulse Avalanche Capability

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

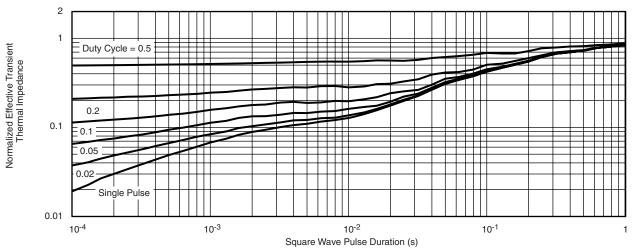
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

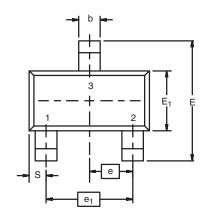


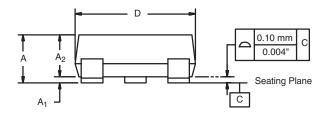
Normalized Thermal Transient Impedance, Junction-to-Case

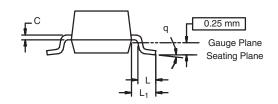
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?73533.



SOT-23 (TO-236): 3-LEAD







Dim	MILLIMETERS		INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.9	5 BSC	0.037	4 Ref	
e ₁	1.9	0 BSC	0.074	8 Ref	
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025 Ref		
S	0.5	0.50 Ref 0.020 R) Ref	
q	3°	8°	3°	8°	
FCN: S-03946-Rev K 09-	lul-01	•			

ECN: S-03946-Rev. K, 09-Jul-01

DWG: 5479

Document Number: 71196 www.vishay.com 09-Jul-01





Mounting LITTLE FOOT® SOT-23 Power MOSFETs

Wharton McDaniel

Surface-mounted LITTLE FOOT power MOSFETs use integrated circuit and small-signal packages which have been been modified to provide the heat transfer capabilities required by power devices. Leadframe materials and design, molding compounds, and die attach materials have been changed, while the footprint of the packages remains the same.

See Application Note 826, Recommended Minimum Pad Patterns With Outline Drawing Access for Vishay Siliconix MOSFETs, (http://www.vishay.com/doc?72286), for the basis of the pad design for a LITTLE FOOT SOT-23 power MOSFET footprint. In converting this footprint to the pad set for a power device, designers must make two connections: an electrical connection and a thermal connection, to draw heat away from the package.

The electrical connections for the SOT-23 are very simple. Pin 1 is the gate, pin 2 is the source, and pin 3 is the drain. As in the other LITTLE FOOT packages, the drain pin serves the additional function of providing the thermal connection from the package to the PC board. The total cross section of a copper trace connected to the drain may be adequate to carry the current required for the application, but it may be inadequate thermally. Also, heat spreads in a circular fashion from the heat source. In this case the drain pin is the heat source when looking at heat spread on the PC board.

Figure 1 shows the footprint with copper spreading for the SOT-23 package. This pattern shows the starting point for utilizing the board area available for the heat spreading copper. To create this pattern, a plane of copper overlies the drain pin and provides planar copper to draw heat from the drain lead and start the process of spreading the heat so it can be dissipated into the ambient air. This pattern uses all the available area underneath the body for this purpose.

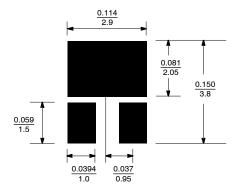


FIGURE 1. Footprint With Copper Spreading

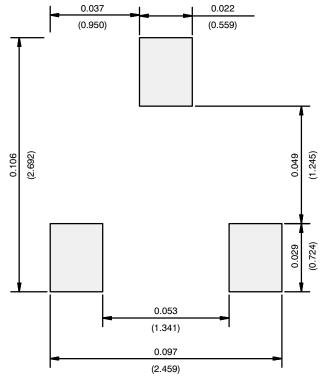
Since surface-mounted packages are small, and reflow soldering is the most common way in which these are affixed to the PC board, "thermal" connections from the planar copper to the pads have not been used. Even if additional planar copper area is used, there should be no problems in the soldering process. The actual solder connections are defined by the solder mask openings. By combining the basic footprint with the copper plane on the drain pins, the solder mask generation occurs automatically.

A final item to keep in mind is the width of the power traces. The absolute minimum power trace width must be determined by the amount of current it has to carry. For thermal reasons, this minimum width should be at least 0.020 inches. The use of wide traces connected to the drain plane provides a low-impedance path for heat to move away from the device.

Document Number: 70739 26-Nov-03



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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